Search Notes			

Application/Control No	. Applicant(s)/Patent under Reexamination
09/810,324	SCHEIN ET AL.
Examiner	Art Unit
Hai Tran	2623

SEARCHED				
Class	Subclass	Date	Examiner	
725	40,50,60- 61	4/3/2006	HVT	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEAR (INCLUDING S	CH NOTES EARCH STRATEGY	·)
	DATE	EXMR
East attached	4/3/2006	HVT